

OCM SpectroNet Collaboration Conference 2019

Photonic Sensors and Systems for the Optical Characterization of Materials

12.03.2019

Fraunhofer-Institut für Optronik, Systemtechnik und Bildauswertung (IOSB)
Fraunhoferstraße 1, 76131 Karlsruhe, Germany



OCM 2019



The **OCM SpectroNet Collaboration Conference 2019** addresses recent developments in innovative photonic micro sensors with digital image processing for **geo-, color-, multi-, hyper- and full-spectral photonic measurement applications for the optical characterization of materials** in industry, biology/medicine, environment and security and in daily life.

The SpectroNet Collaboration Conferences (SCC) are a series which are addressing customers as well as researchers, developers and application engineers. SCCs are connecting actively research & development, products & services, marketing & sales as well as education & training.



Participants of the OCM SpectroNet Collaboration Conference 2017, 21.03.2017, Karlsruhe

Well-known experts from leading companies and research institutions will give methodical, scientific, technical and social insights on their latest developments in photonic measurement engineering for quality assurance for the optical characterization of materials.

There will be **27 presentations** in the following **3 sessions**:

- Photonic Highspeed + Hyperspectral Sensors for the Optical Characterization of Materials
- Innovative Measurement Systems for the Optical Characterization of Materials
- New Developments for the Optical Characterization of Materials

There will also be an **exhibition** of products and services for photonic microsensors and systems as well as a **get-together** event with individual networking.

All further information can be found at: www.spectronet.de

SpectroNet c/o Technologie- und Innovationspark Jena GmbH | Hans-Knöll-Straße 6, 07745 Jena, Germany | Tel.: +49 (0) 3641 6751 00, Fax: +49 (0) 3641 6751 11, E-Mail: info@spectronet.de, URL: www.spectronet.de | IBAN: DE61 8208 0000 0343 8119 00 | BIC: DRES DEFF 827

SpectroNet Conferences 2019:

OCM SpectroNet Collaboration Conference 2019

Topic: Optical Characterization of Materials

Date: 12.03.2019

Venue: Karlsruhe, Germany

Partner: Fraunhofer IOSB

Link: www.spectronet-events.de

OCM 2019

CHII Academy 2019

Topic: Lectures & Workshops on Hyperspectral Imaging in Industry

Date: 23.05.-24.05.2019

Venue: Graz, Austria

Partner: Perception Park GmbH

Link: www.chiiacademy.com / www.chii2019.com



JENCOLOR SpectroNet Collaboration Conference 2019

Topic: Photonic Sensors and Systems for mobile Measurement Engineering for Quality Assurance

Date: 28.08.-29.08.2019

Venue: Jena, Germany

Partner: ams Sensors Germany GmbH

Link: www.spectonet.de



IMEKO Joint TC1 - TC2 International Symposium 2019

Topic: Photonics and Education in Measurement Science

Date: 17.09.-19.09.2019

Venue: Jena, Germany

Partner: Technische Universität Ilmenau

Link: www.imeko-jena.com



All further information can be found at: www.spectronet.de

Contact:

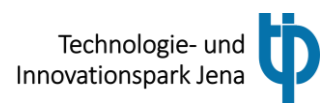


Dr. Nick Leithold
Clustermanager
+49 (0) 176 2441 8167
n.leithold@spectronet.de



M.A. Mariela Sievers
Manager Assistance
+49 (0) 3641 6343 6015
m.sievers@spectronet.de

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